

Product data sheet

1. General description

PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a leadless ultra small DFN1010D-3 (SOT1215) Surface-Mounted Device (SMD) plastic package with visible and solderable side pads.

NPN complement: PBSS4230QA.

2. Features and benefits

- Very low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain h_{FE} at high I_C
- High energy efficiency due to less heat generation
- Reduced Printed-Circuit Board (PCB) area requirements
- Solderable side pads
- AEC-Q101 qualified

3. Applications

- Loadswitch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

4. Quick reference data

| Table 1. Qu | iick reference data | | | | | |
|--------------------|--|---|-----|-----|-----|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| V _{CEO} | collector-emitter voltage | open base | - | - | -30 | V |
| I _C | collector current | | - | - | -2 | А |
| I _{CM} | peak collector current | $t_p \le 1 \text{ ms}; \text{ pulsed}$ | - | - | -3 | А |
| R _{CEsat} | collector-emitter saturation resistance | $\label{eq:lc} \begin{array}{l} I_C = -1 \text{ A}; I_B = -100 \text{ mA}; \text{ pulsed}; \\ t_p \leq 300 \mu\text{s}; \delta \leq 0.02 ; T_{amb} = 25 ^\circ\text{C} \end{array}$ | - | 120 | 180 | mΩ |





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5. Pinning information

| Table 2. | Pinning | information | | |
|----------|---------|-------------|---------------------------------|----------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | В | base | | С |
| 2 | E | emitter | | в- |
| 3 | С | collector | 4 3 | ۲۳ ۲۳ |
| 4 | С | collector | Image: 2 Transparent top view | sym132 |
| | | | DFN1010D-3 (SOT1215) | |

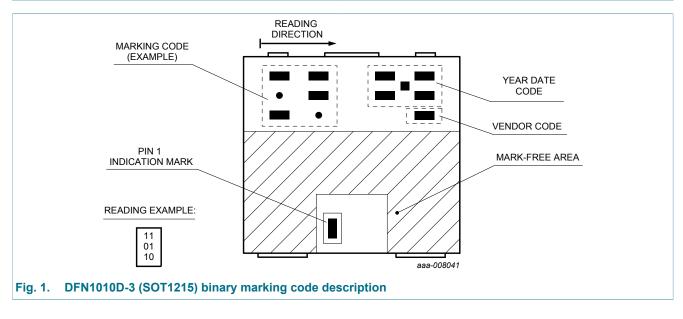
6. Ordering information

| Table 3. Ordering inf | formation | | | | |
|-----------------------|------------|--|---------|--|--|
| Type number | Package | | | | |
| | Name | Description | Version | | |
| PBSS5230QA | DFN1010D-3 | plastic thermal enhanced ultra thin small outline package; no leads; 3 terminals | SOT1215 | | |

7. Marking

Table 4. Marking codes

| Type number | Marking code |
|-------------|--------------|
| PBSS5230QA | 00 00 10 |



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8. Limiting values

Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|------------------|---------------------------|--------------------------|-----|-----|------|------|
| V _{CBO} | collector-base voltage | open emitter | | - | -30 | V |
| V _{CEO} | collector-emitter voltage | open base | | - | -30 | V |
| V _{EBO} | emitter-base voltage | open collector | | - | -7 | V |
| I _C | collector current | | | - | -2 | А |
| I _{CM} | peak collector current | $t_p \le 1 ms$; pulsed | | - | -3 | А |
| I _B | base current | | | - | -0.3 | А |
| I _{BM} | peak base current | $t_p \le 1 ms$; pulsed | | - | -1 | А |
| P _{tot} | total power dissipation | T _{amb} ≤ 25 °C | [1] | - | 325 | mW |
| | | | [2] | - | 600 | mW |
| | | | [3] | - | 740 | mW |
| | | | [4] | - | 540 | mW |
| | | | [5] | - | 1000 | mW |
| Tj | junction temperature | | | - | 150 | °C |
| T _{amb} | ambient temperature | | | -55 | 150 | °C |
| T _{stg} | storage temperature | | | -65 | 150 | °C |

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 1 cm².

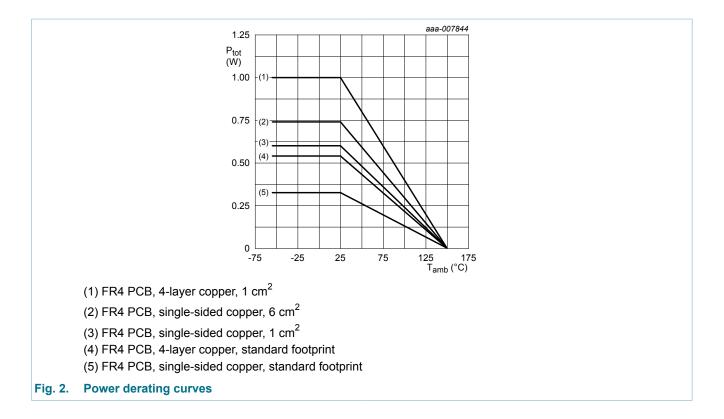
[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 6 cm².

[4] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.

^[5] Device mounted on an FR4 PCB, 4-layer copper, tin-plated mounting pad for collector 1 cm².

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9. Thermal characteristics

| Table 6. T | Thermal characteristics | | | | | | |
|--|-------------------------|------------|-----|-----|-----|-----|------|
| Symbol | Parameter | Conditions | | Min | Тур | Мах | Unit |
| R _{th(j-a)} thermal resistance from junction to ambient | in free air | [1] | - | - | 385 | K/W | |
| | | [2] | - | - | 209 | K/W | |
| | | [3] | - | - | 169 | K/W | |
| | | | [4] | - | - | 232 | K/W |
| | | | [5] | - | - | 125 | K/W |

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 1 cm².

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 6 cm².

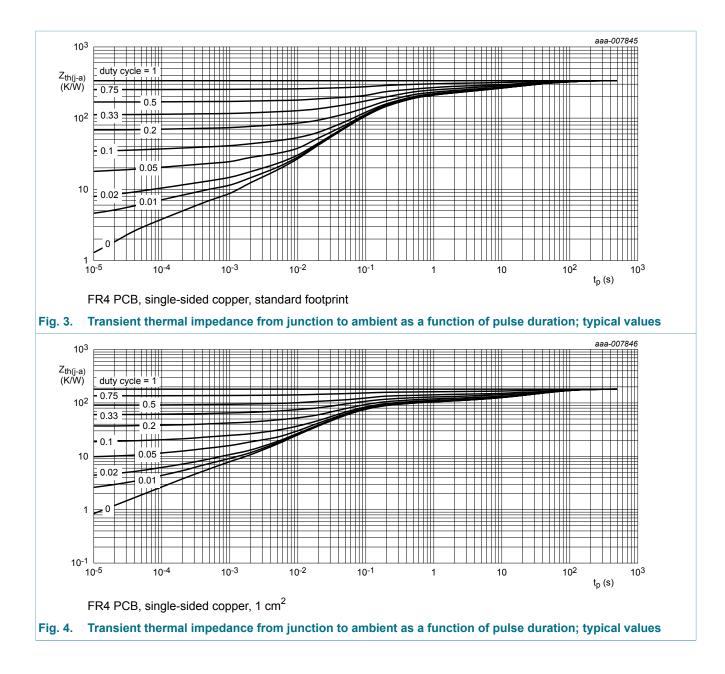
[4] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.

^[5] Device mounted on an FR4 PCB, 4-layer copper, tin-plated mounting pad for collector 1 cm².

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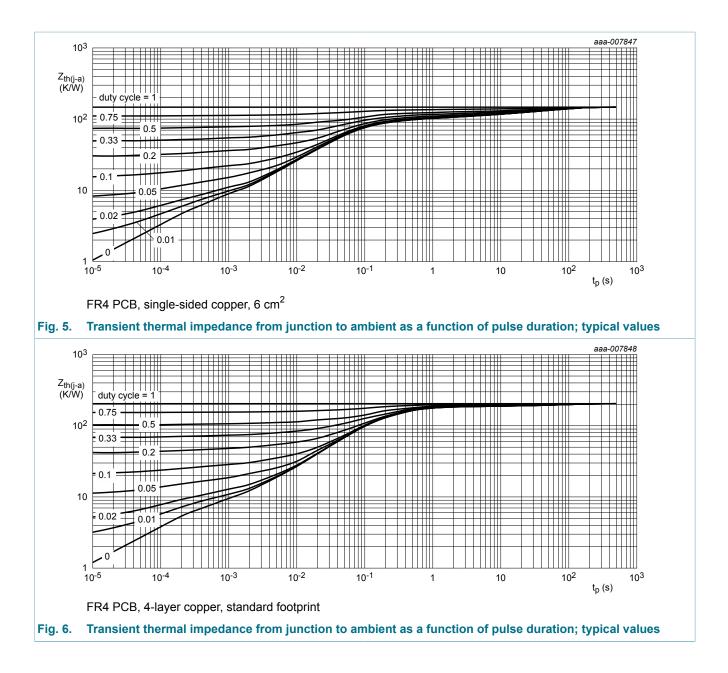
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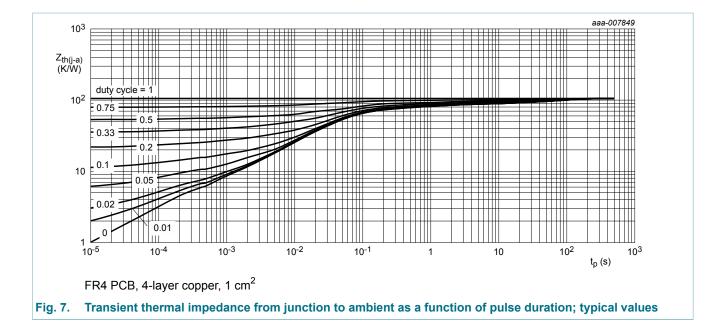
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10. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Мах | Unit |
|---|-----------------------------------|---|-----|------|------|------|
| I _{CBO} | collector-base cut-off | V _{CB} = -24 V; I _E = 0 A; T _{amb} = 25 °C | - | - | -100 | nA |
| | current | V_{CB} = -24 V; I _E = 0 A; T _j = 150 °C | - | - | -50 | μA |
| I _{CES} | collector-emitter cut-off current | V_{CE} = -24 V; V_{BE} = 0 V; T_{amb} = 25 °C | - | - | -100 | nA |
| I _{EBO} | emitter-base cut-off current | V _{EB} = -5 V; I _C = 0 A; T _{amb} = 25 °C | - | - | -100 | nA |
| h _{FE} DC current gair | DC current gain | $V_{CE} = -2 \text{ V; } I_C = -100 \text{ mA; } t_p \le 300 \mu\text{s;}$ $\delta \le 0.02 \text{ ; } T_{amb} = 25 \text{ °C; } \text{pulsed}$ | 250 | 425 | - | |
| | | $\label{eq:VCE} \begin{array}{l} V_{CE} \texttt{=} \texttt{-2} \; V \texttt{;} \; I_{C} \texttt{=} \texttt{-500 mA}\texttt{;} \; t_{p} \texttt{\leq} \texttt{300 } \mu \texttt{s}\texttt{;} \\ \\ \overline{o} \texttt{\leq} \texttt{0.02} \; \texttt{;} \; T_{amb} \texttt{=} \texttt{25} \; ^{\circ} C\texttt{;} \; pulsed \end{array}$ | 180 | 295 | - | |
| | | $\label{eq:Vce} \begin{split} V_{CE} &= -2 \; V; \; I_C = -1 \; A; \; t_p \leq 300 \; \mu s; \\ \bar{\delta} &\leq 0.02 \; ; \; T_{amb} = 25 \; ^\circ C; \; pulsed \end{split}$ | 130 | 200 | - | |
| | | V_{CE} = -2 V; I _C = -2 A; t _p ≤ 300 µs; $\delta \le 0.02$; T _{amb} = 25 °C; pulsed | 60 | 95 | - | |
| V _{CEsat} collector-emitter saturation voltage | | I_C = -500 mA; I_B = -50 mA; t_p ≤ 300 μs; δ ≤ 0.02 ; T_{amb} = 25 °C | - | -70 | -100 | mV |
| | | I_C = -1 A; I_B = -50 mA; t_p ≤ 300 μs; δ ≤ 0.02 ; T_{amb} = 25 °C | - | -140 | -210 | mV |
| | | I _C = -1 A; I _B = -100 mA; pulsed; t _p ≤ 300 μs; δ ≤ 0.02 ; T _{amb} = 25 °C | - | -120 | -180 | mV |

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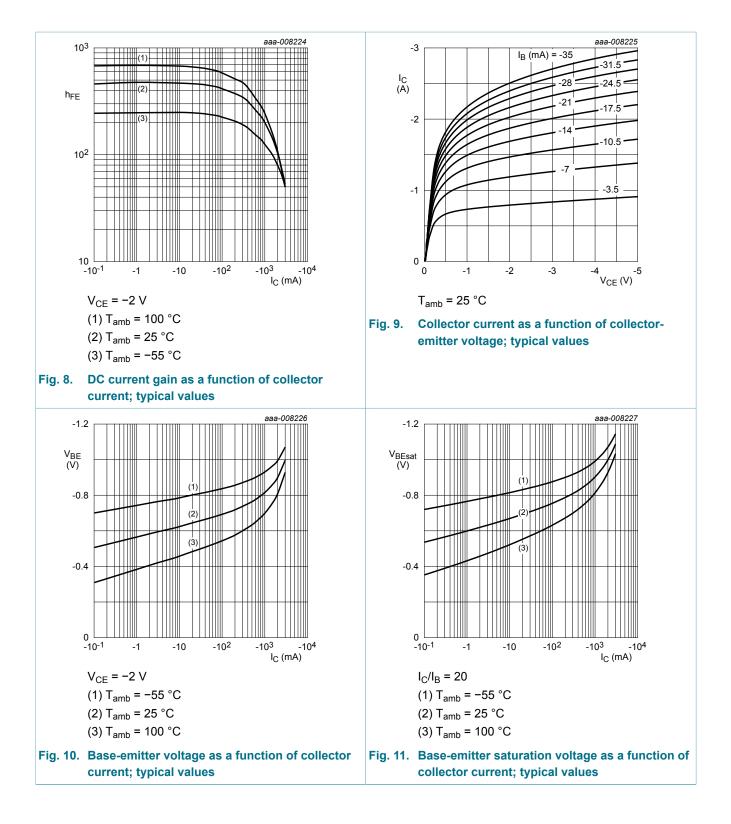
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| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|---|--|-----|-------|-------|------|
| | | I_{C} = -2 A; I_{B} = -100 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C | - | -275 | -410 | mV |
| | | I_{C} = -2 A; I_{B} = -200 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C | - | -220 | -330 | mV |
| R _{CEsat} | collector-emitter saturation resistance | I_{C} = -1 A; I_{B} = -100 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C | - | 120 | 180 | mΩ |
| V _{BEsat} base-emitter saturation voltage | base-emitter saturation voltage | I _C = -500 mA; I _B = -50 mA; pulsed; t _p ≤ 300 μs; δ ≤ 0.02 ; T _{amb} = 25 °C | - | -0.86 | -1 | V |
| | | I_{C} = -1 A; I_{B} = -50 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C | - | -0.89 | -1.05 | V |
| | | I_{C} = -2 A; I_{B} = -100 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C | - | -0.98 | -1.15 | V |
| | | I_{C} = -2 A; I_{B} = -200 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; T_{amb} = 25 °C | - | -1.02 | -1.2 | V |
| V _{BEon} | base-emitter turn-on voltage | V_{CE} = -2 V; I _C = -0.5 A; pulsed; t _p ≤ 300 µs; δ ≤ 0.02 ; T _{amb} = 25 °C | - | -0.77 | -0.9 | V |
| t _d | delay time | V_{CC} = -10 V; I_{C} = -0.5 A; I_{Bon} = -25 mA; | - | 10 | - | ns |
| t _r | rise time | I _{Boff} = 25 mA; T _{amb} = 25 °C | - | 30 | - | ns |
| t _{on} | turn-on time | | - | 40 | - | ns |
| t _s | storage time | | - | 270 | - | ns |
| t _f | fall time | | - | 45 | - | ns |
| t _{off} | turn-off time | | - | 315 | - | ns |
| f _T | transition frequency | V_{CE} = -10 V; I _C = -50 mA; f = 100 MHz; T _{amb} = 25 °C | 120 | 170 | - | MHz |
| C _c | collector capacitance | V _{CB} = -10 V; I _E = 0 A; i _e = 0 A; f = 1 MHz; T _{amb} = 25 °C | - | 14 | 16 | pF |

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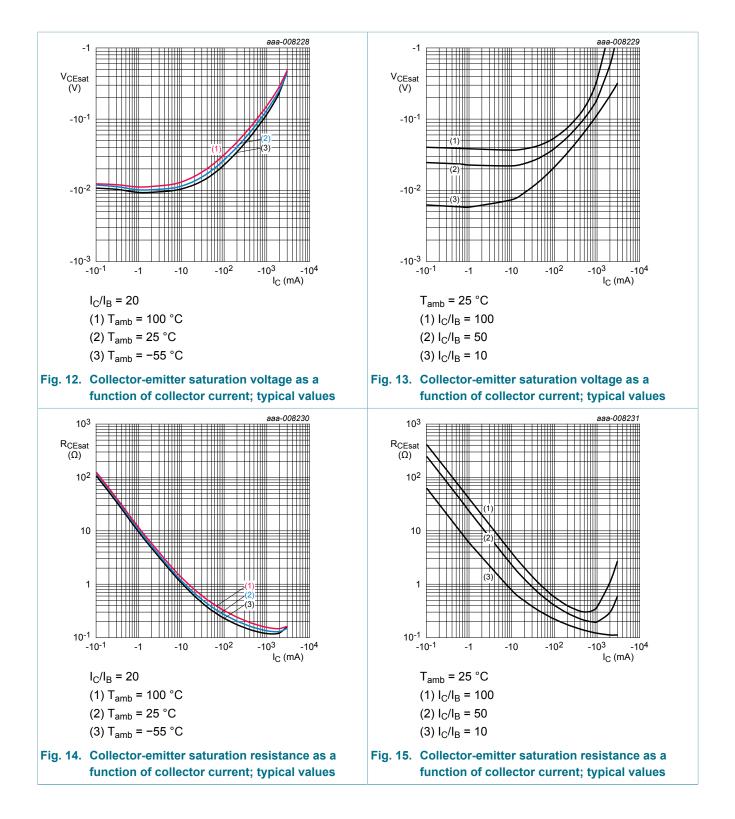
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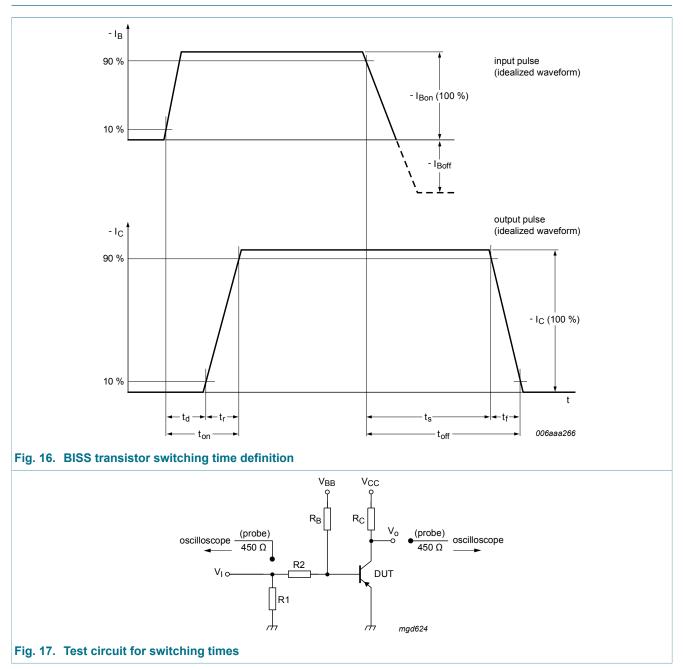
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11. Test information

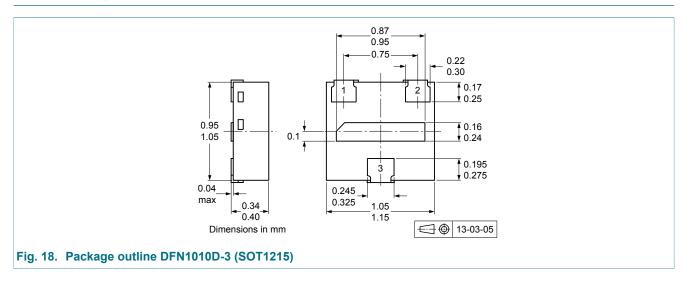


This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

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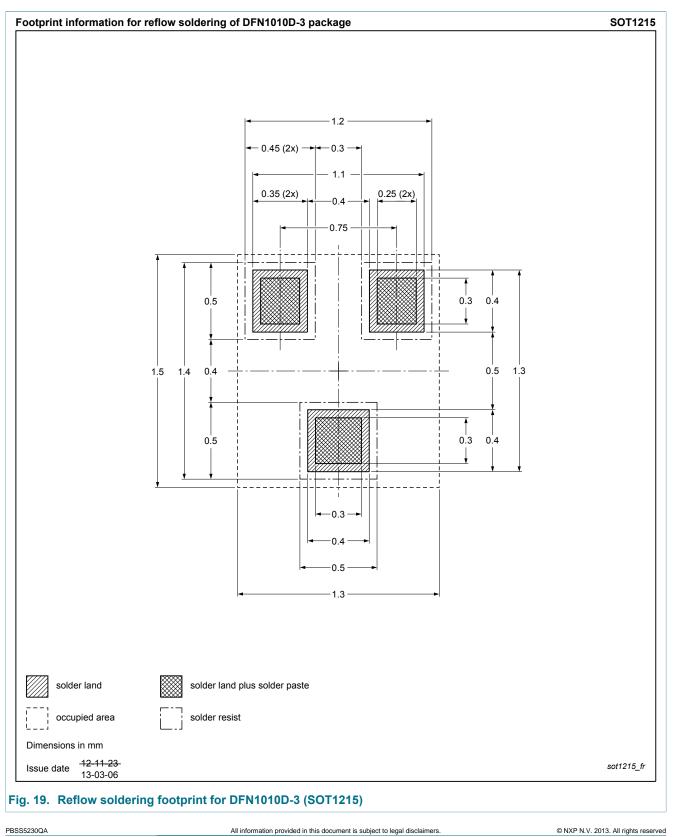
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12. Package outline



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13. Soldering



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14. Revision history

| Table 8. Revision history | | | | |
|---------------------------|--------------|--------------------|---------------|------------|
| Data sheet ID | Release date | Data sheet status | Change notice | Supersedes |
| PBSS5230QA v.1 | 20130823 | Product data sheet | - | - |

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15. Legal information

15.1 Data sheet status

| Document status [1][2] | Product status [<u>3]</u> | Definition |
|--------------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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